### PD - 97598

### **AUTOMOTIVE GRADE**

#### Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dV/dT Rating

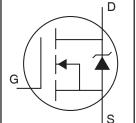
International

**TOR** Rectifier

- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

#### Description

Specifically designed for Automotive applications, this HEXFET<sup>®</sup> Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



AUII	
HEXFET®	Power MOSFET
V <sub>DSS</sub>	100V
B <sub>po(an</sub> ) typ	<b>8 0m</b> O

ALLIDER//10

R <sub>DS(on)</sub>	typ.	<b>8.0m</b> Ω
	max.	<b>10m</b> Ω
I <sub>D (Silicon</sub>	Limited)	88A
I <sub>D (Packag</sub>	je Limited)	75A



G	D	S
Gate	Drain	Source

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature ( $T_A$ ) is 25°C, unless otherwise specified.

Symbol	Parameter	Ма	ax.	Units
$_{\rm D}$ @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	<b>88</b> ①		A
<sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	6	3	7
<sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	7	5	7
DM	Pulsed Drain Current <sup>©</sup>	38	30	1
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	20	00	W
	Linear Derating Factor	1.	.3	W/°C
/ <sub>GS</sub>	Gate-to-Source Voltage	±	20	V
dv/dt	Peak Diode Recovery ④	1	V/ns	
ſj	Operating Junction and	-55 to + 175		С°
Г <sub>STG</sub>	Storage Temperature Range			
	Soldering Temperature, for 10 seconds	30	00	1
	(1.6mm from case)			
	Mounting torque, 6-32 or M3 screw	10lb∙in (	1.1N·m)	
Avalanche Ch	aracteristics			•
AS (Thermally limited)	Single Pulse Avalanche Energy ③	220		mJ
AR	Avalanche Current ①	See Fig. 14, 15, 16a, 16b		A
AR	Repetitive Avalanche Energy S			mJ
Thermal Resis	tance			
Symbol	Parameter	Тур.	Max.	Units

Symbol	Parameter	Typ.	Max.	Units
$R_{ ext{ heta}JC}$	Junction-to-Case ®		0.61	
R <sub>0CS</sub>	Case-to-Sink, Flat Greased Surface	0.50		°C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient		62	

HEXFET® is a registered trademark of International Rectifier.

\*Qualification standards can be found at http://www.irf.com/

### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.094		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA <sup>®</sup>
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		8.0	10	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 58A ⑤
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_D = 150 \mu A$
gfs	Forward Transconductance	120			S	$V_{DS} = 50V, I_{D} = 58A$
R <sub>G</sub>	Gate Input Resistance		1.5		Ω	f = 1MHz, open drain
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 100V, V_{GS} = 0V$
				250		$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200		V <sub>GS</sub> = -20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		120	180	nC	I <sub>D</sub> = 58A
Q <sub>gs</sub>	Gate-to-Source Charge		31			$V_{DS} = 80V$
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		44			V <sub>GS</sub> = 10V ⑤
t <sub>d(on)</sub>	Turn-On Delay Time		24		ns	$V_{DD} = 65V$
t <sub>r</sub>	Rise Time		80			I <sub>D</sub> = 58A
t <sub>d(off)</sub>	Turn-Off Delay Time		55			$R_{G} = 4.1\Omega$
t <sub>f</sub>	Fall Time		50			V <sub>GS</sub> = 10V ⑤
C <sub>iss</sub>	Input Capacitance		5150		pF	$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		360			$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		190			f = 1.0MHz
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		420			$V_{GS} = 0V, V_{DS} = 0V$ to 80V $\odot$ , See Fig.11
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related)®		500			$V_{GS} = 0V, V_{DS} = 0V$ to 80V ©, See Fig. 5

#### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current			<b>88</b> ①	Α	MOSFET symbol
	(Body Diode)					showing the
I <sub>SM</sub>	Pulsed Source Current			380	Α	integral reverse
	(Body Diode) ②					p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 58A, V <sub>GS</sub> = 0V ⑤
t <sub>rr</sub>	Reverse Recovery Time		38	56	ns	$T_J = 25^{\circ}C$ $V_R = 85V$ ,
			51	77	1	$T_J = 125^{\circ}C$ $I_F = 58A$
Q <sub>rr</sub>	Reverse Recovery Charge		61	92	nC	T <sub>J</sub> = 25°C di/dt = 100A/μs ⑤
			110	170		$T_{\rm J} = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		2.8		Α	$T_{\rm J} = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

#### Notes:

- ① Calculated continuous current based on maximum allowable junction ⑥ Coss eff. (TR) is a fixed capacitance that gives the same charging time temperature. Package limitation current is 75A.
- 2 Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by T\_Jmax, starting T\_J = 25°C, L = 0.14mH  $R_G$  = 25 $\Omega,~I_{AS}$  = 58A,  $V_{GS}$  =10V. Part not recommended for use above this value.
- $\label{eq:ISD} \textcircled{0.5mu}{0.5mu} I_{SD} \leq 58A, \ di/dt \leq 650A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- (5) Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.

- as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 80%  $V_{\text{DSS}}.$
- $\oslash$  Coss eff. (ER) is a fixed capacitance that gives the same energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 80%  $V_{\text{DSS}}.$
- $\ensuremath{\textcircled{B}}$  R<sub>heta</sub> is measured at T<sub>J</sub> approximately 90°C.

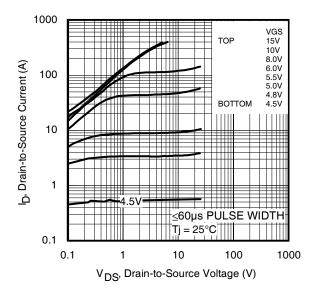
## **Qualification Information<sup>†</sup>**

			Automotive				
			(per AEC-Q101) <sup>††</sup>				
Qualification I	_evel	Comments: This part number(s) passed Automoti qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotion level.					
Moisture Sens	sitivity Level	TO-220AB	TO-220AB N/A				
	Machine Model		Class M4 (425V)				
			AEC-Q101-002				
	Human Body Model		Class H1C (2000V)				
ESD			AEC-Q101-001				
	Charged Device Model		Class C5 (1125V)				
			AEC-Q101-005				
RoHS Complia	ant		Yes				

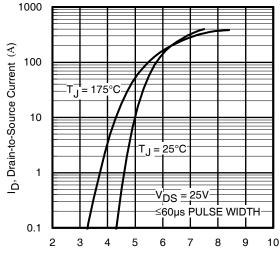
† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

**††** Exceptions to AEC-Q101 requirements are noted in the qualification report.

# International **IOR** Rectifier

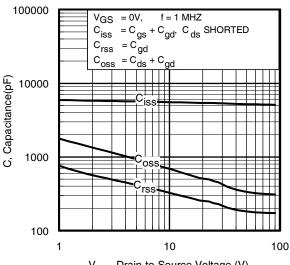






 $V_{GS}$ , Gate-to-Source Voltage (V)





V<sub>DS</sub>, Drain-to-Source Voltage (V)

Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

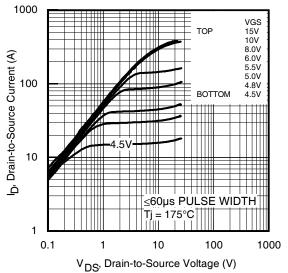


Fig 2. Typical Output Characteristics

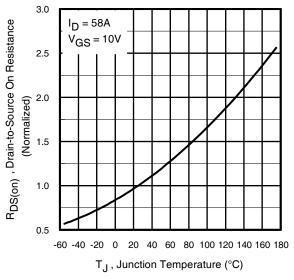


Fig 4. Normalized On-Resistance vs. Temperature

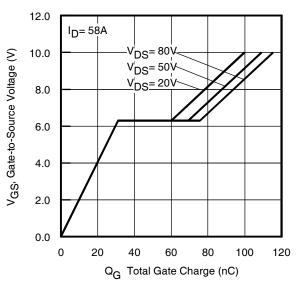


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

# International

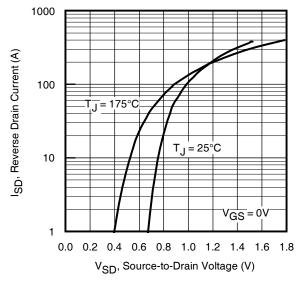


Fig 7. Typical Source-Drain Diode Forward Voltage

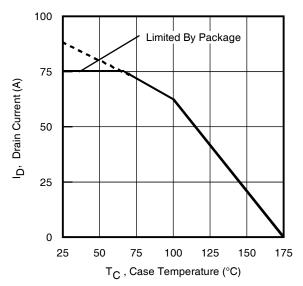
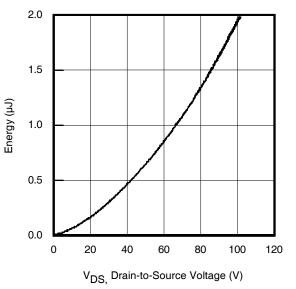


Fig 9. Maximum Drain Current vs. Case Temperature



**Fig 11.** Typical C<sub>OSS</sub> Stored Energy www.irf.com

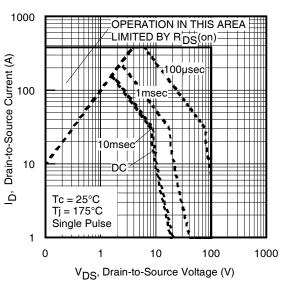


Fig 8. Maximum Safe Operating Area

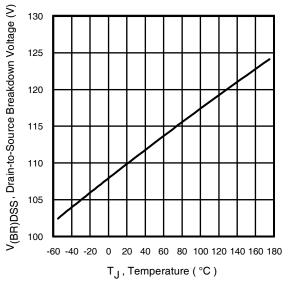


Fig 10. Drain-to-Source Breakdown Voltage

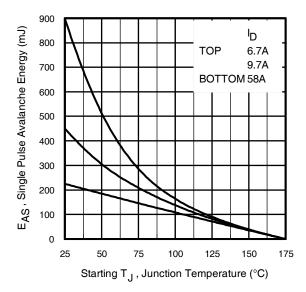


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

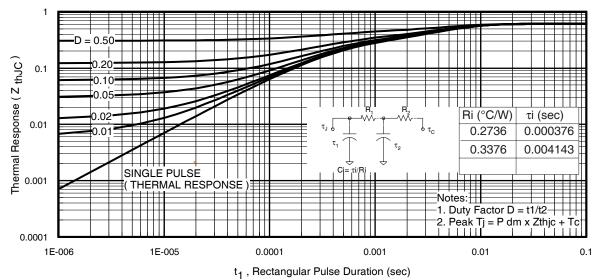


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

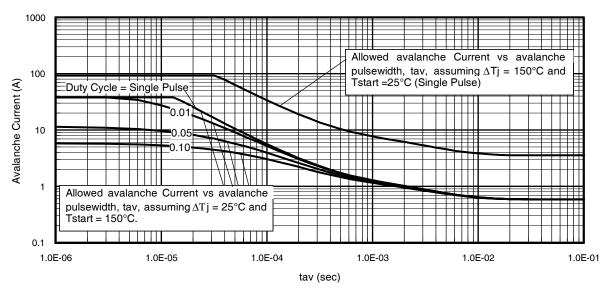


Fig 14. Typical Avalanche Current vs.Pulsewidth

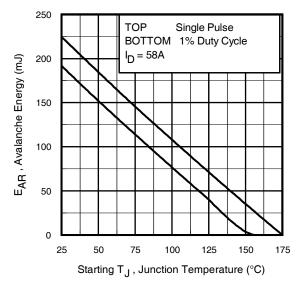


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com) 1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.

- Safe operation in Avalanche is allowed as long as neither T<sub>jmax</sub> nor I<sub>av (max)</sub> is exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6.  $I_{av}$  = Allowable avalanche current.
- 7.  $\Delta$ T = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 14, 15).

tav = Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

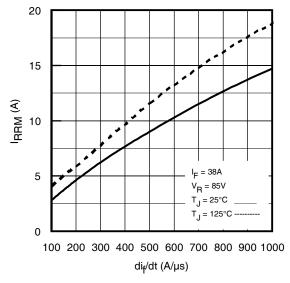
 $Z_{thJC}(D, t_{av}) =$  Transient thermal resistance, see Figures 13)

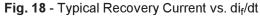
$$\begin{split} \textbf{P}_{D \;(ave)} &= 1/2 \; ( \; \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; [\textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS \;(AR)} &= \textbf{P}_{D \;(ave)} \cdot \textbf{t}_{av} \end{split}$$

#### **TOR** Rectifier 5.0 4.5 V<sub>GS(th)</sub> Gate threshold Voltage (V) 4.0 3.5 3.0 = 150µA 2.5 250µA D 1.0mA חו 2.0 .0A n 1.5 1.0 -75 -50 -25 0 25 50 75 100 125 150 175 200 T<sub>J</sub>, Temperature ( °C )

International

Fig 16. Threshold Voltage vs. Temperature





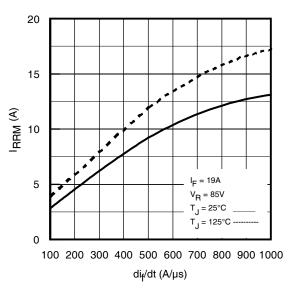


Fig. 17 - Typical Recovery Current vs. dif/dt

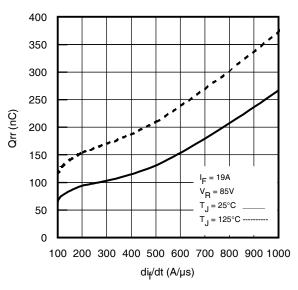


Fig. 19 - Typical Stored Charge vs. dif/dt

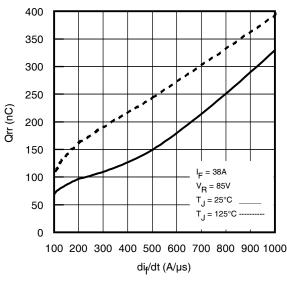
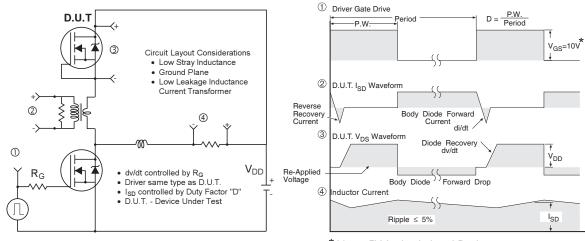


Fig. 20 - Typical Stored Charge vs. dif/dt



\*  $V_{GS}$  = 5V for Logic Level Devices

Fig 20. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET<sup>®</sup> Power MOSFETs

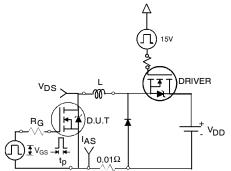


Fig 21a. Unclamped Inductive Test Circuit

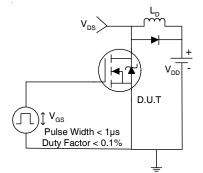


Fig 22a. Switching Time Test Circuit

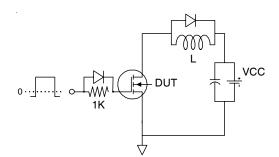


Fig 23a. Gate Charge Test Circuit

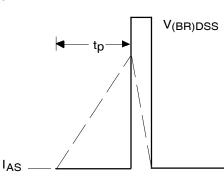


Fig 21b. Unclamped Inductive Waveforms

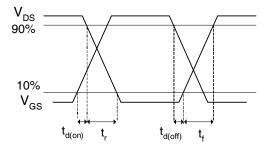


Fig 22b. Switching Time Waveforms

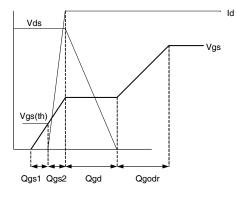
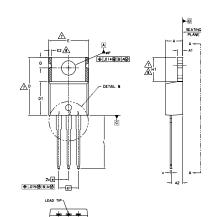


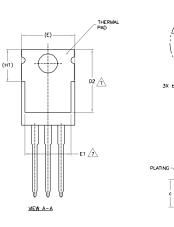
Fig 23b. Gate Charge Waveform

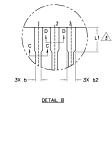
International **TOR** Rectifier

## **TO-220AB** Package Outline

Dimensions are shown in millimeters (inches)







b2`

b1,b3-- 1 SECTION C-C & D-D

BASE METAL

c1/5

NOTES S: DMENSIONING AND TOLERANGING AS PER ASME Y14.5 M- 1994. DMENSIONS ARE SHOWN IN INCHES [MILIMETERS] LEAD DMENSION AND FINISH UNCONTROLLED IN L1. DMENSION D IA & E DO NOT INCLUE MOLD TLASH. MOLD FLASH SHALL NOT EXCEED .005' (0.127) PER SDE THESE DMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. DMENSION D I, b3 & c1 APPLY TO BASE META. ONLY. CONTROLLING DMENSION : INCHES. THERMAL PAGE CONTOUR OPTIONAL WITHIN DMENSIONS E.H.1.02 & E1 DMENSION D IS X HI DEFINE A ZONE WHERE STAMPING AND SINGLATION IRREGULARITES ARE ALLOWED. DUTLINE CONFORMS TO JEDIC TO-220, EXCEPT A2 (mox.) AND D2 (min.) WHERE DMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE. 1,-2,-3,-4.-

- <u>6.-</u> 7.-
- 8.-

9. –

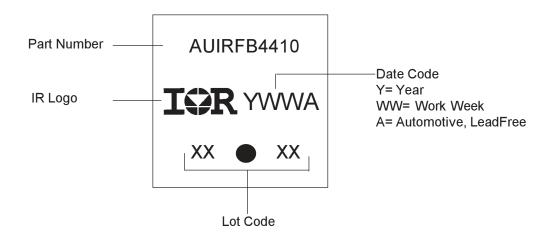
SYMBOL	MILLIM	ETERS	INC		
	Min.	MAX.	Min.	MAX.	NOTES
A	3.56	4.83	.140	.190	
A1	0.51	1.40	.020	.055	
A2	2,03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0,97	.015	.038	5
b2	1,14	1,78	.045	.070	
b3	1.14	1,73	.045	.068	5
с	0,36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
e		2.54 BSC .100 BSC			
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3,56	4.06	.140	.160	3
øР	3,54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

HEXFET - gate - drain - sourc 1, 2, IGBTs, CoPACK 1.- GATE 2.- COLLECT 3.- ENITTER

LEAD ASSIGNMENTS

DIODES CATHO

### **TO-220AB Part Marking Information**



TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

www.irf.com

# **Ordering Information**

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRFB4410	TO-220	Tube	50	AUIRFB4410

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